

Editorial Objectives

The **Journal of Testing and Evaluation** is published bimonthly by ASTM, a nonprofit technical organization that develops and publishes voluntary consensus standards and related information for materials, products, systems, and services. All contributions are peer reviewed prior to publication.

The editorial objectives of this journal are to serve a broad-based audience by:

- Publishing new technical information derived from the field and laboratory testing, performance, quantitative characterization, and evaluation of these materials, products, systems, and services.
- 2. Presenting new methods and data and critical evaluations of these methods and data.
- 3. Reporting the users' experience with test methods and the results of interlaboratory testing and analysis.
- **4**. Providing the scientific basis for both new and improved ASTM standards.
- Stimulating new ideas in the fields of testing and evaluation.

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Commentary (500-1000 words)

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- Letters to the Editor.
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The subject matter must not be of a speculative nature and the contents must not include materials of an advertising nature. The paper must not be seriously defective as to literary form and structure, continuity of thought, and clarity of expression. The substance of the paper should not have been published previously in the open literature.

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